

Gd_{1.33}Pt₃(Al,Si)₈ and Gd_{0.67}Pt₂(Al,Si)₅: Two Structures Containing a Disordered Gd/Al Layer Grown in Liquid Aluminum

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Gd_{1.33}Pt₃Al₈ was synthesized by the combination of Gd and Pt in excess liquid aluminum. Addition of silicon resulted in the incorporation of a small amount of this element into the material to form the isostructural Gd_{1.33}Pt₃Al₇Si. Both compounds grow as rodlike crystals with hexagonal cross section. The structures were refined in the rhombohedral space group $R\bar{3}m$, with cell parameters a = 4.3359(6) Å and c = 38.702(8) Å for the ternary and a = 4.3280(8)Å and c = 38.62(1) Å for the quaternary compound. The structure is comprised of stuffed arsenic-like PtAl₂ layers and disordered Gd/Al layers. Analysis of the *hk*0 zone reflections indicate the presence of an $a^* = \sqrt{3}a$ supercell, but the structure is not ordered along *c*, as revealed by the highly diffuse reflections in the 0*kl* zone photos. Therefore, the compounds are disordered variants of the Gd₄Pt₉Al₂₄ type. Magnetic susceptibility studies reveal antiferromagnetic transitions at 15 K for the ternary and 7 K for the quaternary compound. Variation of the reactant ratio produces a different structure comprised of the same structural blocks, including the disordered Gd/Al layer. Gd_{0.67}Pt₂Al₅ and its quaternary analogue Gd_{0.67}Pt₂Al₄Si form in the hexagonal system *P*6₃/mmc with cell parameters a = 4.2907(3) Å and c = 16.388(2) Å for the ternary and a = 4.2485(6) Å and c = 16.156(3) Å for the quaternary compound.

Introduction

Synthesis in a flux medium offers a great advantage in growing high-quality crystals of a number of compounds. Large crystals of refractory borides such as TiB₂, VB₂, and LaB₆ can be grown from aluminum flux.¹ Gallium nitride can be grown from the combination of gallium metal and NaN₃; heating this mixture causes the azide to decompose to nitrogen (the source of nitrogen for GaN) and sodium (which acts as the flux for crystal growth).² Flux growth has also allowed for the determination of crystal structures of refractory compounds previously only isolable as powders via the standard high-temperature synthesis routes. For instance, gallium flux was used to grow large crystals of YNiSi₃, which allowed the structure and properties of this compound to be determined.³

Low melting fluxes are even more useful in exploratory synthesis. A number of new compounds with complex stoichiometries have been discovered recently by combining a rare earth element, a late transition metal, and a group 14 element in liquid aluminum or gallium. With nickel alone, a plethora of new structures have resulted, such as RENiAl₄- $\text{Ge}_{2,4}$ RE₂Ni(Ni_xSi_{1-x})Al₄Si₆,⁵ RE_{0.67}Ni₂Ga₄Ge⁶ (RE = rare earth), and the aforementioned YNiSi₃.³ The flux acts as a solvent to a wide range of reactants, particularly for group 14 elements silicon and germanium, which are rendered active at temperatures well below their normal melting points. Lower temperatures generally facilitate the formation of kinetically derived materials that may not be accessible by traditional high-temperature synthetic methods such as arc melting or rf heating. Even within the flux growth scenario, variation of the reaction time and temperature can influence the product outcome within a system.

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 $\textbf{Table 1.} Crystallographic Data and Structural Refinement Parameters for Gd_{1.33}Pt_3Al_8, Gd_{1.33}Pt_{3.0}Al_{6.7}Si_{1.0}, Gd_{0.67}Pt_2Al_5, and Gd_{0.67}Pt_2Al_4Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_{1.0}Si_$

	Gd _{1.33} Pt ₃ Al ₈	Gd _{1.33} Pt ₃ Al ₇ Si	$Gd_{0.67}Pt_2Al_5$	Gd _{0.67} Pt ₂ Al ₄ Si
fw	1010.26	1011.37	630.45	631.55
space group	$R\overline{3}m$	$R\overline{3}m$	P63/mmc	P6 ₃ /mmc
a (Å)	4.3359(6)	4.3280(8)	4.2907(3)	4.2482(6)
$c(\mathbf{A})$	38.702(8)	38.62(1)	16.388(2)	16.156(3)
$V(Å^3)$	630.12	626.52	261.28	252.51
Z	3	3	2	2
$d_{\rm calc}$ (g/cm ³)	7.987	8.042	8.014	8.307
temp (°C)	25	25	25	25
radiation	Μο Κα	Μο Κα	Μο Κα	Μο Κα
$\mu ({\rm mm^{-1}})$	38.82	19.53	33.32	32.31
$R1/wR2 [I > 2\sigma(I)]^a$	0.0208/0.0476	0.0351/0.0903	0.0231/0.0551	0.0300/0.0693
R1/wR2 (all data)	0.0245/0.0487	0.0377/0.0913	0.0271/0.0565	0.0309/0.0700

Our exploration of complex intermetallics grown from liquid aluminum and gallium has recently been extended to incorporate the third row transition metals. Syntheses using gold have resulted in a number of new phases such as the $Th_2(Au_xSi_{1-x})[AuAl_2]_nSi_2$ series, characterized by the presence of AuAl₂ slabs of varying widths.⁷ Platinum is being investigated for comparison and in anticipation of a similar broad range of new structures. Platinum intermetallics are also of interest for use as catalysts⁸ and for high-temperature applications such as inert coatings for titanium alloys.9 Here we report the structural and magnetic properties of four Gd/ Pt/(Al,Si) intermetallic compounds grown from liquid aluminum. Their structure features platinum atoms in a stuffed arsenic type coordination environment and a monatomic plane of rare earth ions and triangles of aluminum atoms which exhibits extensive stacking disorder. In the Gd_{1,33}Pt₃-(Al,Si)₈ structure, this disorder results in a higher apparent symmetry than is present in the recently reported ordered archetype Gd₄Pt₉Al₂₄, which is comprised of the same building blocks.¹⁰ The relationship between these compounds will be discussed.

Experimental Procedure

Synthesis. In a nitrogen-filled glovebox, Gd (Cerac, 99.9%), Pt powder (Alfa-Aesar, 99.95%), Al pellets (Cerac, 99.99%), and Si (Cerac, 99.9%) were combined in a 1:1:10:5 molar ratio in an alumina crucible. This was placed into a fused silica tube which was sealed under a vacuum of 10⁻⁴ Torr. This sample was then heated to 1000 °C in 12 h, held at this temperature for 15 h, cooled to 860 °C in 1 day, annealed at 860 °C for 2 days, and slowly cooled to room temperature over 3 days. The aluminum flux was removed by soaking the crucible in 5 M NaOH for 1 day. Single crystals were selected from the product for elemental analysis, X-ray diffraction, and magnetic susceptibility measurements. The yield of Gd_{1.33}Pt₃Al₇Si was very low (10%, based on rare earth), so additional syntheses were explored in an attempt to increase the vield. A synthesis carried out without silicon (Gd:Pt:Al ratio 1:1: 12) yielded a ternary version of the compound, Gd_{1.33}Pt₃Al₈, in 12% yield based on Gd. A Gd/Pt/Al/Si reactant ratio of 0.33:1:10: 5, prepared in the same manner, produced Gd_{0.67}Pt₂Al₄Si, a different quaternary compound, in 20% yield based on Gd. Omitting the silicon in this reaction (Gd:Pt:Al ratio 0.33:1:12) resulted in the ternary version Gd_{0.67}Pt₂Al₅, in 25% yield based on Gd. The majority product in all three syntheses was GdAl₃.

EDS Analysis. Selected single crystals were affixed to an SEM plate using carbon tape. Microprobe analysis of these samples was

performed using a JEOL JSM-35C scanning electron microscope equipped with a Tracor Northern energy dispersive spectroscopy (EDS) detector. Data were acquired using a 20 kV accelerating voltage and an accumulation time of 50 s. The elemental ratios in the approximately 60 analyzed crystals from the 1:1:12 and 0.33: 1:12 ternary reactions were very consistent, with average compositions of GdPt₃Al₇ and GdPt₂Al₅, respectively. Crystals isolated from the quaternary reactions were found to have elemental ratios of GdPt₃Al₆Si (from the 1:1:10:5 reactant mixture) and GdPt₂Al₄Si (from the 0.33:1:10:5 synthesis). The Gd:Pt:(Al + Si) ratios observed for all the products are in fair agreement with the results obtained from the X-ray refinement (vide infra), the only discrepancy being slightly low aluminum readings.

X-ray Crystallography. Full-sphere single-crystal X-ray diffraction data for the ternary and quaternary compounds were collected at room temperature on a Bruker AXS SMART CCD diffractometer. Data processing was then performed using the program SAINT; an absorption correction was applied to the data using the SADABS program.11 The structure was solved using direct methods and refined with the SHELXTL package of programs.¹² The crystallographic and refinement data are listed in Tables 1-5. The aluminum and silicon atoms in the quaternary materials could not be distinguished in the X-ray refinement due to their similar number of electrons. Bond length analysis also proved inconclusive, indicating that silicon might be substituting in small amounts on all aluminum sites (vide infra). The refinements were therefore carried out using aluminum on all the possible mixed sites. Bond lengths and angles are shown in Table 6. X-ray photographs of the hk0 and 0kl zones were collected on multiple crystals of the Gd_{1,33}-Pt₃(Al,Si)₈ compounds with 3000 s exposures.

Magnetic Susceptibility Measurements. Magnetic susceptibility measurements were carried out with a Quantum Design SQUID magnetometer at temperatures between 2 and 300 K. For isotropic data, selected crystals were ground into powder and placed into a polypropylene sample holder. Field-cooled and zero-field-cooled

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Table 2. Atomic Positions and Equivalent Isotropic Displacement Parameters (Å²) for $Gd_{1,33}Pt_3Al_8$

atom	site	х	У	Z	$U_{\mathrm{eq}}{}^a$	occ
Gd	6 <i>c</i>	0	0	0.26936(3)	0.0059(4)	0.670(4)
Pt(1)	3a	0	0	0	0.0054(3)	1
Pt(2)	6 <i>c</i>	0	0	0.12071(1)	0.0060(2)	1
Al(1)	6 <i>c</i>	0	0	0.4442(1)	0.0074(9)	1
Al(2)	6 <i>c</i>	0	0	0.1865(1)	0.0073(9)	1
Al(3)	6 <i>c</i>	0	0	0.3507(1)	0.0081(9)	1
Al(4)	18h	0.540(1)	0.460(1)	0.3947(2)	0.010(3)	0.35(1)

^{*a*} In this and subsequent tables, U_{eq} is defined as one-third of the trace of the orthogonalized U_{ii} tensor.

Table 3. Atomic Positions and Equivalent Isotropic Displacement Parameters $(Å^2)$ for Gd_{1,33}Pt_{3.0}Al_{6.7}Si_{1.0}

atom	site	х	У	Z	$U_{ m eq}$	occ
Gd	6 <i>c</i>	0	0	0.26938(5)	0.0054(8)	0.624(7)
Pt(1)	3a	0	0	0	0.0077(5)	1
Pt(2)	6 <i>c</i>	0	0	0.12077(2)	0.0087(5)	1
Al(1)	6 <i>c</i>	0	0	0.4438(2)	0.011(2)	1
Al(2)	6 <i>c</i>	0	0	0.1864(2)	0.011(2)	1
Al(3)	6 <i>c</i>	0	0	0.3511(2)	0.009(2)	1
Al(4)	18h	0.540(2)	0.460(2)	0.3947(3)	0.008(5)	0.29(2)

Table 4. Atomic Positions and Equivalent Isotropic Displacement Parameters $(Å^2)$ for $Gd_{0.67}Pt_2Al_5$

atom	site	Х	У	Z	$U_{ m eq}$	occ
Gd	2c	1/3	2/3	1/4	0.0064(3)	0.690(6)
Pt(1)	4f	1/3	2/3	0.60832(2)	0.0061(2)	1
Al(1)	4e	0	0	0.1345(2)	0.0070(5)	1
Al(2)	4f	1/3	2/3	0.0464(2)	0.0072(5)	1
Al(3)	$6\dot{h}$	0.539(1)	0.077(2)	1/4	0.010(2)	0.37(2)

Table 5. Atomic Positions and Equivalent Isotropic Displacement Parameters $(Å^2)$ for Gd_{0.67}Pt₂Al₄Si

atom	site	х	У	Z	$U_{ m eq}$	occ
Gd	2c	1/3	2/3	1/4	0.0095(9)	0.525(6)
Pt(1)	4f	1/3	2/3	0.61015(4)	0.0104(4)	1
Al(1)	4e	0	0	0.1382(3)	0.013(1)	1
Al(2)	4f	1/3	2/3	0.0479(3)	0.009(1)	1
Al(3)	6h	0.530(1)	0.061(3)	1/4	0.015(4)	0.32(2)

Table 6. Selected Bond Lengths (Å)

	$\begin{array}{c} Gd_{1.33}\text{-}\\ Pt_3Al_8 \end{array}$	$\begin{array}{c} Gd_{1.33}Pt_{3}\text{-}\\ Al_{7}Si \end{array}$		$\begin{array}{c}Gd_{0.67} \\ Pt_2Al_5\end{array}$	Gd _{0.67} - Pt ₂ Al ₄ Si
Pt(1)-Al(4)	2.560(8)	2.55(1)			
Pt(1) - Al(3)	2.592(1)	2.591(2)			
Pt(2) - Al(4)	2.485(7)	2.48(1)	Pt-Al(3)	2.509(3)	2.472(4)
Pt(2)-Al(1)	2.5319(8)	2.530(2)	Pt-Al(1)	2.5141(5)	2.4941(9)
Pt(2)-Al(2)	2.546(5)	2.534(8)	Pt-Al(2)	2.536(3)	2.554(6)
	2.700(2)	2.696(3)		2.677(1)	2.651(2)
Gd-Pt(2)	3.3301(8)	3.325(1)	Gd-Pt	3.3953(3)	3.3348(6)
Gd-Al(4)	$1.556(7)^{a}$	$1.55(1)^{a}$	Gd-Al(3)	$1.525(8)^{a}$	$1.45(1)^{a}$
	3.092(5)	3.09(1)		3.066(6)	3.079(7)
Gd-Al(3)	3.085(3)	3.071(5)	Gd-Al(1)	3.118(2)	3.046(3)
Gd-Al(1)	3.092(3)	3.077(5)	Gd-Al(2)	3.336(3)	3.265(6)
Al(4) - Al(4)	$1.65(1)^{a}$	$1.64(3)^{a}$	Al(3)-Al(3)	$1.65(1)^{a}$	$1.74(2)^{a}$
	2.69(1)	2.69(3)		2.64(1)	2.51(2)

^{*a*} These unreasonable interatomic distances are between partially occupied sites, as explained in the text.

data were collected at 500 G. To determine the anisotropic characteristics of the magnetic behavior, rod-shaped single crystals of $Gd_{1,33}Pt_3(Al,Si)_8$ were aligned along their *c*-axis between layers of Kapton tape. FC and ZFC data sets were collected at 500 G with the *c*-axis aligned parallel and perpendicular to the magnetic field of the SQUID. Field dependence data was also collected at 3 K for both the powder and crystal samples.



Figure 1. Representative crystal of $Gd_{1,33}Pt_3Al_7Si$, showing rodlike morphology and hexagonal cross section. Note the striations on the [100] and [010] faces resulting in a corrugated surface.

Results and Discussion

Gd_{1.33}Pt₃Al₈ and Gd_{1.33}Pt₃Al₇Si crystallize as metalliclooking faceted hexagonal rods which can reach up to 1 mm in length and 0.4 mm in width. Some of the rods are tapered at one end, forming a pencil shape, as seen in Figure 1. The rods also appear to have corrugated surfaces; the corrugation lines are perpendicular to the rod's long direction, probably indicative of stacking faults in the crystals along the *c*-axis (additional support for this hypothesis is discussed below). Gd_{0.67}Pt₂Al₅ and Gd_{0.67}Pt₂Al₄Si also form as hexagonal rods, but they are not characterized by the aforementioned uneven surfaces. These ternary and quaternary intermetallics only account for 10-20% of the solid isolated after removal of the flux. The remaining product consists predominantly of GdAl₃ needles but also contains platelike silicon crystals and crystals of GdAl₂Si₂. Attempts to incorporate a higher amount of silicon into the quaternary structures failed, resulting instead in more recrystallized silicon as a byproduct.

Structure Description. The crystal structure of Gd_{1.33}Pt₃-(Al, Si)₈ is shown in Figure 2. This material adopts a disordered modification of the structure of RE₄Pt₉Al₂₄ (RE = late rare earth; vide infra).¹⁰ The latter was described as triclinic $(P\overline{1})$, but $Gd_{1,33}Pt_3(Al, Si)_8$ was found to crystallize in rhombohedral space group $R\overline{3}m$. This structure can be described as a stacking of three types of layers in a sequence ABCBA'BC'BA"BC"B, where A is a Pt₂Al₄ double layer, B is a disordered Gd/Al layer, and C is a PtAl₂ single layer; see Figures 3 and 4. The positioning of the layers with respect to each other is indicated by A', A", etc.; as discussed in the next sections, the staggering of the Gd/Al layer is not ordered. Gd_{0.67}Pt₂(Al,Si)₅ can be described in hexagonal space group $P6_3/mmc$ and is analogous to the new quaternary phases RE_{0.67}Ni₂Ga_{5-x}Ge_x recently isolated from gallium flux.⁶ The structure of Gd_{0.67}Pt₂(Al,Si)₅ is comprised of two of the building blocks found in the rhombohedral phasealternating Pt₂Al₄ double layers and Gd/Al disordered layers, as seen in Figure 5. The platinum atoms have similar coordination environments in both these structures; the Pt₂-Al₄ slab can be viewed as a linked pair of two PtAl₂ layers.

PtAl₂ Single Layer and Pt₂Al₄ Double Layer. The PtAl₂ slab, shown in Figure 3a, is comprised of a triangular net of



Figure 2. Structure of $Gd_{1.33}Pt_3Al_8$ shown as a stacking of layers for clarity. The absence of drawn bonds between layers is for illustrative purposes only and does not imply that bonding is weak or absent between the layers.



Figure 3. Structural motifs found in the compounds discussed in this work: (a) the $PtAl_2$ slab, showing the local environment of the Pt(1) atom in this layer; (b) the Pt_2Al_4 slab and the local environment of the Pt(2) atom in this layer.

platinum atoms sandwiched between two similar nets of aluminum atoms. This is the same kind of layer found in $Y_2Co_3Ga_9$ and its aluminum analogues¹³ and in SmNiAl₄-Ge₂.⁴ The triangles of aluminum atoms above and below each platinum atom create a highly distorted octahedral environment (severely compressed along the 3-fold axis) for the platinum in this layer. This can also be described as a "stuffed" arsenic type slab, with puckered cyclohexane-like rings centered by a platinum atom. The Al–Al distances are 2.85(5) Å, whereas the Pt–Al distances are 2.591(2) Å. The



Figure 4. Disordered rare earth–aluminum layer found in the compounds discussed in this work: (a) the Gd/Al layer with both sites fully occupied, viewed down the *c*-axis, where the 4.3 Å cell is indicated; (b) the superstructure in the *ab*-plane that results from the partial occupancy of the Gd and Al sites in this layer, where the 7.5 Å supercell is indicated in gray; (c) local environment of Gd in this layer, viewed down the *a*-axis.



Figure 5. Structure of $Gd_{0.67}Pt_2Al_5$. Bonds between the Gd/Al layer and the Pt_2Al_4 layer have been omitted for clarity.

platinum atoms in this layer are also bonded to Al atoms above and below the $PtAl_2$ slab at a distance of 2.56(1) Å.

The Pt_2Al_4 double layer is essentially a pair of $PtAl_2$ single layers staggered and linked through Pt-Al bonds. This results in a layer of 5.5 Å thickness, compared to the 2.6 Å of the single $PtAl_2$ layer. The platinum atoms in the single $PtAl_2$ layer are perfectly centered between the aluminum sheets; in the double Pt_2Al_4 slab, the platinum atoms are pushed toward the capping Al(1) layer, resulting in a very asymmetrical environment shown in Figure 3b.

Disordered Gd/Al Layer. This monatomic layer has similar characteristics in all four structures studied in this work. Understanding the disordered configuration of this layer is key to comprehending the full structure of these compounds. The Gd atoms are situated in a triangular net with 4.3 Å between neighboring sites. The electron density at this site indicated less than complete occupancy, and there was significant residual density in the plane in locations between the Gd triangles. Putting this density into the model as aluminum atoms resulted in a large drop in the R-value.

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Figure 6. Zone photographs for $Gd_{1,33}Pt_3Al_7Si$: (a) the *hk*0 zone photo, which can be indexed on a 7.5 Å supercell ($\sqrt{3}a$) in the *ab*-plane; (b) the *h0l* zone, indicating disorder in the stacking of the various planes along the *c*-axis.

As shown in Figure 4a, the resulting structure is the same triangular net, comprised now of GdAl₃ units. This arrangement possesses unrealistically short Gd-Al and Al-Al distances of 1.45–1.55 and 1.65–1.75 Å, respectively (see the highlighted entries in Table 6). Furthermore, partial occupancies of approximately 66% and 33% were observed for both the Gd and Al atoms in this layer. This phenomenon is a classic symptom of observing an averaged structure through a subcell. In other words, the disordered GdAl₃ layer of Figure 4a is a "collapsed" structure, likely an artifact, deriving from the fact that a larger cell is needed to describe this part of the structure. A supercell with a cell edge of $\sqrt{3a} \times \sqrt{3a}$ (i.e. 7.5 \times 7.5 Å) could explain both the structural motif of Figure 4a and the observed occupancies. Despite this realization we were not able to index the collected diffraction data to larger cells than the ones we report here.

This hexagonal REAl₃ layer appears to have exceptional stability and has been observed in a number of ternary and quaternary intermetallic compounds. Gladyshevskii et al. characterized a family of RENi3Al9 ternary structures which had either ordered arrangements of rare earth atoms and aluminum triangles (for RE = Er and Gd) or partially disordered arrangements of these moieties (for RE = Y and Dy).¹⁴ Favorable comparison of the Al-Al distances in the Al triangles of Gd_{1,33}Pt₃Al₇Si (2.69(3) Å) with those observed in RNi_3Al_9 (2.64 Å) indicates that silicon is likely not substituting on this site. This distance in the other quaternary compound studied here (Gd_{0.67}Pt₂Al₄Si) is significantly shorter at 2.51(2) Å and may indicate the presence of silicon at this site. Si-Si bonds in intermetallics often fall in the 2.35–2.45 Å range; Al–Al bonds are usually over 2.6 Å in length. An intermediate distance of 2.51 Å is reasonable for an Al-Si bond, supporting the possibility of Si substitution in the triangles. This is in contrast to the results of neutron diffraction studies of the gallium and germanium distribution in the isostructural $Y_{0.67}Ni_2Ga_{5-x}Ge_x$, which indicate that gallium and not the tetrelide element preferentially occupies the corresponding triangular sites.⁶

Zone photographs of crystals of Gd_{1.33}Pt₃Al₇Si were taken to investigate the extent of the Gd/Al layer ordering in the compounds studied here. Short *hk*0 zone acquisition times (less than 600 s) reveal only the seven bright spots in Figure 6a. These can be indexed on a 4.3 Å unit cell, outlined in white in the figure. However, considerably longer collection times (3000 s) reveal weak superstructure reflections in a hexagonal pattern, corresponding to the presence of a 7.5 Å cell which is a $\sqrt{3a}$ supercell of the $R\bar{3}m$ structure. These weak reflections are not present in the full sphere data due to the short exposure times (15 s) used. The supercell and the indexing based on it are shown in the figure. The experimental observation of the supercell strongly supports the ordering model proposed in Figure 4b.

The 0kl zone photograph in Figure 6b is also highly informative; it indicates that the supercell is not ordered along the *c*-axis of the structure. Instead of sharp Bragg peaks, the reflections along the *c**-axis are predominantly faint broad streaks. This streaking strongly indicates considerable disorder associated with the stacking of layers along the *c*-axis. The few sharp reflections in this zone photo can be indexed to the 38 Å repeat unit found in our data collection and used in structure refinement. This repeat distance is due to the staggering order of the PtAl₂ and Pt₂Al₄ layers. Indexing along the *k* direction reveals a *b*-axis parameter of 7.5 Å, in agreement with the results of the *hk*0 zone photograph.

Jeitschko et al. recently reported the structure of a series of compounds RE₄Pt₉Al₂₄ with RE = late rare earth metals.¹⁰ These materials are comprised of identical layers as the Gd_{1.33}Pt₃(Al,Si)₈ compounds discussed here, but the rare earth—aluminum layers are ordered. The nature of this ordering varies with the rare earth. For Er₄Pt₉Al₂₄, the Er/Al layer is ordered not only within the layer but also in its positioning with respect to the other layers in the unit cell (i.e., it has an ordered staggering arrangement). This destroys the 3-fold rotational symmetry, because while each kind of layer in the compound possesses a 3-fold axis, these axes do not coincide with each other. The result is a $P\bar{1}$ triclinic cell, albeit with *a*- and *b*-cell edges that are very similar and a γ angle close to 60° (a = 7.461 Å, b = 7.462 Å, c =13.044 Å; $\alpha = 90.00^\circ$, $\beta = 100.94^\circ$, $\gamma = 60.13^\circ$). For Y₄-

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Pt₉Al₂₄, on the other hand, this ordering is not complete. Analysis of the refinement results using the same triclinic cell indicated the presence of residual electron density in the Y/Al layer corresponding to misplaced layers (with their atoms being shifted by \pm [1/3,1/3] in the *ab*-plane). When these out-of-register sites were included in the refinement, their low occupancies (<20%) indicated a fairly small amount of disorder in the stacking and orientation of the layers.¹⁰

Each slab extending in the *ab*-plane in the Gd_{1.33}Pt₃(Al,-Si)₈ structure (and by similar reasoning, the Gd_{0.67}Pt₂(Al,-Si)₅ structure) is ordered. The stacking and registry however of the PtAl₂ and Pt₂Al₄ slabs with respect to the Gd/Al monatomic layers—which possesses a 7.5 Å \times 7.5 Å ordered configuration in the *ab*-plane-is not. The lack of registry of the slabs along c renders the structure unable to develop a stable and coherent lattice *c*-constant. Thus, the reciprocal lattice points along c^* become extremely large, i.e., diffuse, as seen in the 0kl zone photos which show streaks instead of distinct reflections along the l direction. All this however does not affect the superstructure in the *ab*-plane which is apparent in the hk0 zone photos. It is this lack of order that makes it appropriate to use the structural formula Gd_{1,33}Pt₃- Al_8 to emphasize that this compound is a disordered, averaged subcell of the ordered parent compound Gd₄Pt₉-Al₂₄.

The disorder in the positioning of the Gd/Al planes in Gd_{1.33}Pt₃Al₈ is likely the result of the short reaction times that were used in this study. During synthesis, these compounds were annealed at 860 °C for only 2 days. While the more ordered compounds studied by Jeitschko et al. were also grown from aluminum flux, a much longer annealing time (300 h at 850 °C) was used. Promotion of ordering by long heating times is a relatively commonly observed phenomenon. Recent studies on $GdNi_{5-x}Tr_x$ (Tr = Al, Ga, In), a family of intermetallic compounds of interest for hydrogen storage, have shown that the crystal structure of some of the materials is very dependent on heat treatment.¹⁵ While as-cast alloys of GdNi₃Ga₂ crystallize in the CaCu₅ structure type, lengthy annealing times result in an ordering of the nickel and gallium to form a superstructure of the YCo₃Ga₂ type.

A survey of the published structures with similar layers of rare earth ions and triangles of aluminum (or gallium) also indicates the importance of reaction conditions in promoting ordering. Aluminide analogues of the Y₂Co₃Ga₉ structure have been synthesized with a variety of rare earth and transition metals; examples include Ce₂Ir₃Al₉ and Ce₂-Rh₃Al₉.^{13,16}This structure consists of the stuffed arsenic type slab (see the PtAl₂ layer, Figure 3a) alternating with the REAl₃ triangle layer. In all published accounts of these compounds, arc melting followed by lengthy (5 or more days) annealing at high temperatures was used as the



Figure 7. Isotropic magnetic susceptibility of a polycrystalline sample of $Gd_{1,33}Pt_3Al_7Si$. The inset shows a more detailed view of the low temperature χ_m vs *T* behavior.

synthetic technique, and the REAl₃ layer is ordered. RENi₃-Al₉ also contains this layer, alternating with a Ni₂Al₅ slab that can be related to the Pt₂Al₄ layer described herein (shown in Figure 3b) by the addition of another layer of Al atoms. Four analogues of this structure were synthesized by arc melting, followed by annealing at 1073 K for 2 weeks.14 The Gd and Er compounds were found to have no disorder in the RE/Al triangle layer. The Y and Dy analogues had partial disorder corresponding to the presence of some RE/ Al layers being shifted out of alignment along a specific vector, similar to the situation described for Y₄Pt₉Al₂₄. However, it was noted that a structure with maximum disorder in this layer would result in an averaged higher symmetry, changing the space group from R32 to P6m2. This kind of disorder was not observed.¹⁴ It appears that the higher temperatures afforded by arc melting and high temperature annealing promote the formation of the thermodynamically favored ordered arrangement of REAl₃ triangle layers, as the lengthy annealing time did in the Al flux growth of RE4Pt9-Al₂₄. Experiments are currently underway to investigate the effects of longer annealing times on the disordered Gd_{1,33}-Pt₃Al₈ materials synthesized in this work.

Magnetic Susceptibility Studies. Because of the disorder present in these structures, and the anisotropic environment and triangular distribution of gadolinium ions, these compounds have the potential for interesting magnetic characteristics such as spin glass behavior. To investigate this possibility, magnetic susceptibility measurements were carried out on powdered samples and oriented crystals. The magnetic susceptibility data for a polycrystalline sample of Gd_{1.3}Pt₃Al₇Si are shown in Figure 7. This compound exhibits Curie–Weiss behavior above 50 K; the magnetic moment/ gadolinium atom derived from these data (8.3 $\mu_{\rm B}$) is in agreement with the theoretical value for free Gd^{3+} ions (7.94) $\mu_{\rm B}$). The high-temperature data for the ternary Gd_{1.3}Pt₃Al₈ and the Gd_{0.67}Pt₂(Al,Si)₅ compounds are similar. This indicates that platinum is diamagnetic in these materials, and it is consistent with the many examples of nonmagnetic late transition metals (TM's) in rare-earth containing interme-

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Gd_{1.33}Pt₃(Al,Si)₈ and Gd_{0.67}Pt₂(Al,Si)₅

tallics. The electronegativity of the metals in the Fe, Co, Ni, and Cu families (all >1.8 on the Pauling scale, with platinum at 2.2) is greater than that of aluminum (1.5) and silicon (1.8).¹⁷ Thus, in ternary or quaternary materials RE/TM/Al-(Si), the electrons donated by the rare earth ions will likely be accepted to a large extent by the transition metal, filling up the d-orbitals and resulting in no magnetic moment on the TM atoms. Evidence of this has been seen in compounds such as Gd₃Ni₆Al₂,¹⁸ RERu₂Al₁₀,¹⁹ and SmNiSi₃.³

Antiferromagnetic ordering is indicated in the data for $Gd_{1,33}Pt_3Al_8$ by a cusp in the temperature dependence of χ_m at 20 K. This is consistent with the negative Weiss constant of -35 K derived from the inverse susceptibility fit. The data for the silicon containing quaternary compound are more complex, showing a discontinuity at 15–20 K (a slight dip) and a more pronounced antiferromagnetic cusp at 7 K. This could be an indication of local nanoscopic inhomogeneities in composition, with Si-rich regions of the sample alternating with Si-poor regions. The latter could behave much like the ternary Gd_{1,33}Pt₃Al₈ with an antiferromagnetic transition at 15 K. In Si-rich regions of the sample, the disorder is greater and therefore the exchange energy between the gadolinium ions is lower, resulting in the antiferromagnetic transition being shifted to lower temperature (7 K). Similar evidence of disorder hindering the magnetic interactions between rare earth ions has been observed in an investigation of the Laves phase GdAl₂ doped with a variety of nonmagnetic species to form a series of $Gd(Al_{1-x}M_x)_2$.²⁰ As the concentration of M increases, the Curie temperature of this compound decreased; it is noteworthy that the effect was most drastic for M = silicon. This correlated well with calculated changes in the value of the DOS at $E_{\rm f}$ as a dopant was added.

This doping effect is also apparent in the data for the Gd_{0.67}Pt₂(Al,Si)₅ compounds. As shown in Figure 8, the ternary compound Gd_{0.67}Pt₂Al₅ undergoes antiferromagnetic ordering at 8 K. For the silicon-containing analogue, no transition is seen down to 3 K, although fitting of the data shows a negative Weiss constant, indicative of an antiferromagnetic exchange interaction. It is interesting that even though Gd_{0.67}Pt₂(Al,Si)₅ contains the same disordered Gd/ Al planes and Pt_2Al_4 layers as $Gd_{1,3}Pt_3(Al,Si)_8$, the magnetic ordering is shifted down to lower temperatures. This may indicate that the observed coupling in Gd_{1.3}Pt₃(Al,Si)₈ takes place across the PtAl₂ layers. This layer separates two Gd/ Al layers at a distance of 5.5 Å, as opposed to the 8.3 Å distance across the Pt₂Al₄ moiety. However, proximity of the magnetic ions to one another is only one of the two main factors that control magnetic interactions in metallic compounds. In conducting materials, the conduction electrons mediate exchange between localized moments; the strength of the interaction is therefore dependent on the band structure



Figure 8. Isotropic magnetic susceptibility of a polycrystalline sample of Gd_{0.67}Pt₂Al₅. The field-cooled (FC) and zero-field-cooled (ZFC) susceptibility data are labeled.

at the Fermi level, as well as the distribution of spins.²¹ It is not known how the DOS at $E_{\rm f}$ of these two structure types differ.

The magnetic behavior of $Gd_{0.67}Pt_2(Al,Si)_5$ and $Gd_{1.33}Pt_3$ -(Al,Si)₈ may be further complicated by the disorder in the Gd/Al layers. The superstructure model of the Gd/Al plane shown in Figure 4b indicates that each Gd has three nearest Gd neighbors at a distance of 4.3 Å. Even if each Gd/Al slab is thus ordered, the lack of superstructure peaks in the X-ray data indicates that the layers are not ordered with respect to each other. This has the potential to result in unusual magnetic phenomena. Evidence of this possibility is found in the divergence of the isotropic field-cooled (FC) and zero-field-cooled (ZFC) susceptibility, examples of which are seen in Figures 7 and 8. This FC–ZFC hysteresis behavior is often found in spin glass systems.²²

Single-Crystal Magnetic Susceptibility Measurements. The anisotropic nature of the Gd_{1.3}Pt₃(Al,Si)₈ structure, with layers containing rare earth ions separated by nonmagnetic layers, is likely to produce strong orientation dependence in the magnetic behavior. Because the orientation of the layers was obvious from the crystal morphology, the directional dependence of the magnetic susceptibility was investigated. Figure 9 shows an expanded view of the anisotropic lowtemperature data for both compounds. Theoretically, a material with localized electrons that order antiferromagnetically with their spins aligned along the magnetic field should show a precipitous drop in χ_m below the Neel temperature. If the spins are aligned along a direction perpendicular to the field, χ_m should level off as the temperature drops below $T_{\rm N}$. If one looks at the data for Gd_{1,3}-Pt₃(Al,Si)₈ as a function of crystal orientation, it is apparent that the spins are lying in the basal plane when ordered. The "parallel" and "perpendicular" descriptions in the legend of

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Figure 9. Magnetic susceptibility data for crystals of $Gd_{1.33}Pt_3Al_8$ and $Gd_{1.33}Pt_3Al_7Si$ oriented with their *c*-axes parallel and perpendicular to the magnetic field. A log scale is used for the temperature axis to emphasize the low-temperature region.

Figure 9 refer to the orientation of the *c*-axis with respect to the field. It is when the crystals are placed in the field with their *c*-axes perpendicular to the field that the drop in χ_m characteristic of spins aligned along the field of the magnet occurs. Conversely, when the *c*-axes of the crystals are aligned parallel to the field, a leveling off of χ_m is seen (the slight rise below T_N is due to the presence of a small amount of paramagnetic impurities).

Concluding Remarks

The combination of Gd, Pt, and Si in molten aluminum has resulted in the formation of compounds with two

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structure types containing similar structural motifs. In addition to stuffed arsenic-type PtAl₂ layers, both structure types also possess a Gd/Al triangle layer. The low reaction temperatures afforded by synthesis in aluminum flux has allowed for highly disordered positioning of these Gd/Al layers, in contrast to the ordered stacking of similar layers in other compounds synthesized by arc melting followed by annealing. Gd_{1.33}Pt₃Al₇Si can be described as a pseudoternary disordered variant of Gd₄Pt₉Al₂₄; the same variant structure is also formed without silicon (Gd_{1.33}Pt₃Al₈). Gd_{0.67}Pt₂Al₄Si and its ternary analogue are isostructural with RE_{0.67}Ni₂Ga_{5-x}Ge_x. A specific crystallographic site for silicon has not been located in either structure.

The antiferromagnetic coupling between the Gd^{3+} ions in $Gd_{1.33}Pt_3Al_8$, with a T_N of 20 K, is suppressed by the addition of silicon into the structure, lowering the ordering temperature to 7 K. Orientation dependence of the susceptibility indicates anisotropic exchange forces, in agreement with the layered nature of the structure.

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Supporting Information Available: Additional X-ray crystallographic data such as anisotropic thermal parameters and complete tables of bond distances and angles for all four compounds are available in CIF format. This material is available free of charge via the Internet at http://pubs.acs.org.

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